Interview Summary	Application No.	Applicant(s)
	10/046,261	TAKAGAWA ET AL.
	Examiner	Art Unit
	Tuan T Dinh	2827
All participants (applicant, applicant's representative, PTO personnel):		
(1) <u>Tuan T Dinh</u> .	(3)	
(2) Juan Carlos A. Marquez.	(4)	
Date of Interview: 11 September 2003.		
Type: a)⊠ Telephonic b)□ Video Conference c)□ Personal [copy given to: 1)□ applicant 2	2) applicant's representative)]
Exhibit shown or demonstration conducted: d) Yes If Yes, brief description:	e) No.	
Claim(s) discussed:		
Identification of prior art discussed:		
Agreement with respect to the claims f)⊠ was reached. g)□ was not reached. h)□ N/A.		
Substance of Interview including description of the general nature of what was agreed to if an agreement was reached, or any other comments: <u>See Continuation Sheet</u> .		
(A fuller description, if necessary, and a copy of the amendments which the examiner agreed would render the claims allowable, if available, must be attached. Also, where no copy of the amendments that would render the claims allowable is available, a summary thereof must be attached.)		
THE FORMAL WRITTEN REPLY TO THE LAST OFFICE A INTERVIEW. (See MPEP Section 713.04). If a reply to the GIVEN ONE MONTH FROM THIS INTERVIEW DATE, OR FORM, WICHEVER IS LATER, TO FILE A STATEMENT OF Summary of Record of Interview requirements on reverse states.	e last Office action has already THE MAILING DATE OF THE OF THE SUBSTANCE OF THE	been filed, APPLICANT IS S INTERVIEW SUMMARY
	SUPERVISORY TECHNOLS	MINIO MUENTEN JAEN INTER 2200
Examiner Note: You must sign this form unless it is an Attachment to a signed Office action.	Examiner's sign	nature, if required

Continuation of Substance of Interview including description of the general nature of what was agreed to if an agreement was reached, or any other comments:

Election/Restrictions

Specie I. Claims 1-9 are drawn to a semiconductor device comprising a power supply circuit, and two field effect transistors (FETs) as shown in figure 1.

Specie II. Claims 10-15 are drawn to a semiconductor device comprising horizontal and vertical FET's as shown in figure.5

Specie III. Claims 16-17 are drawn to a semiconductor device with one FET, as shown in figure.8

Specie IV. Claim 18, drawn to a semiconductor device with two FET, as shown in figure.6A

Because these inventions are distinct for the reasons given above and the search required for any of Group I-IV is not required for the other of Group I-IV, restriction for examination purposes as indicated is proper.

Therefore, Mr. Juan Carlos A. Marquez was contact on September 11, 2003 for an election restriction. Mr. Marquez elected claims 1-9 without traverse to expedite prosecution of the invention. Claims 10-18 are withdrawn from further consideration by the examiner, 37 CFR 1.142(b), as being drawn to a non-elected invention.

As claims 1-9 are allowable, Mr. Marquez also agreed to cancel claims 10-18 to allow claims 1-9 to be issued. Applicant authorizes examiner to do examiner's amendment.